

Notice of References Cited	Application/Control No. 10/730,782		Applicant(s)/Patent Under Reexamination CHRISTENSEN ET AL.	
	Examiner Philip B. Tran		Art Unit 2155	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,807,565	10-2004	Dodrill et al.	709/227
*	B	US-7,111,044	09-2006	Lee, Jin Woo	709/204
*	C	US-7,039,675	05-2006	Kato, Masami	709/204
*	D	US-6,564,261	05-2003	Gudjonsson et al.	709/227
*	E	US-7,039,040	05-2006	Burg, Frederick Murray	370/352
*	F	US-7,047,030	05-2006	Forsyth, John Matthew	455/518
*	G	US-6,175,619	01-2001	DeSimone, Antonio	379/202.01
*	H	US-5,737,011	04-1998	Lukacs, Michael Edward	348/14.09
*	I	US-6,931,114	08-2005	Martin, Dannie E.	709/204
*	J	US-6,721,703	04-2004	Jackson et al.	704/270
*	K	US-2005/0102358	05-2005	Gold et al.	709/204
*	L	US-2004/0221224	11-2004	Blattner et al.	715/500.1
*	M	US-2005/0128997	06-2005	Zhao et al.	370/349

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.